

General Description

The GL609-4B uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications. The package form is TO-252-4, which accords with the RoHS standard.

Features

● N channel

- $V_{DS}=40V, I_D=23A$
- $R_{DS(ON)} < 20m\Omega @ V_{GS}=10V$
- $R_{DS(ON)} < 25m\Omega @ V_{GS}=4.5V$

● P channel

- $V_{DS} = -40V, I_D = -20A$
- $R_{DS(ON)} < 30m\Omega @ V_{GS} = -10V$
- $R_{DS(ON)} < 50m\Omega @ V_{GS} = -4.5V$

Application

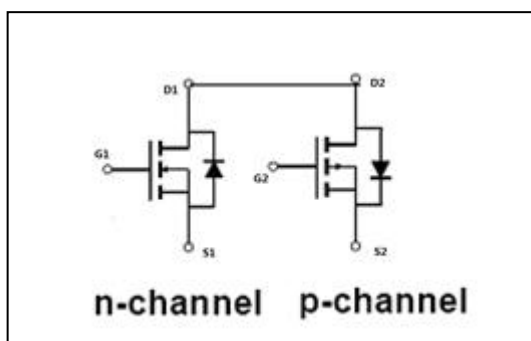
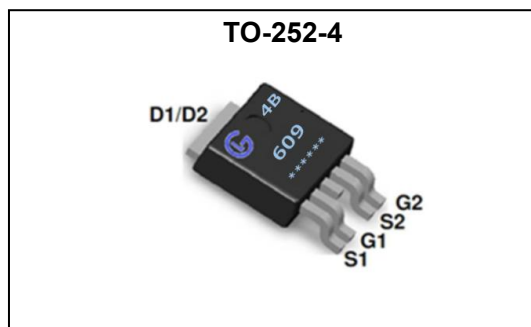
- H-bridge
- Inverters

Absolute Maximum Ratings ($T_C=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	N-Channel	P-Channel	Unit
Drain-Source Voltage	V_{DS}	40	-40	V
Gate-Source Voltage	V_{GS}	± 20	± 20	V
Continuous Drain Current	I_D	23	-20	A
		19.5	-18	
Pulsed Drain Current (Note 1)	I_{DM}	46	-40	A
Maximum Power Dissipation	P_D	40		W
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 To 150		$^\circ\text{C}$

Thermal Characteristic

Parameter	Symbol	Rating	Unit
Thermal Resistance, Junction-to-Case (Note 2)	$R_{\theta JC}$	3.1	$^\circ\text{C/W}$





GL609-4B

GL Silicon N+P Channel Power MOSFET

N-CH Electrical Characteristics (TA=25°C unless otherwise noted)

Parameter	Symbol	Condition	Rating			Unit
			Min	Typ	Max	
Off Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	40	--	--	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =40V,V _{GS} =0V	--	--	1	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±10V,V _{DS} =0V	--	--	±10	μA
On Characteristics (Note 3)						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =250μA	1	1.5	2.5	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =12A	--	--	20	mΩ
		V _{GS} =4.5V, I _D =10A	--	--	25	mΩ
Forward Transconductance	g _{FS}	V _{DS} =5V,I _D =12A	5	--	--	S
Dynamic Characteristics (Note4)						
Input Capacitance	C _{iss}	V _{DS} =15V,V _{GS} =0V, F=1.0MHz	--	680	--	PF
Output Capacitance	C _{oss}		--	78	--	PF
Reverse Transfer Capacitance	C _{rss}		--	56	--	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	t _{d(on)}	V _{DD} =20V, R _L =2.5Ω V _{GS} =4.5V,R _{GEN} =3Ω	--	8.9	--	nS
Turn-on Rise Time	t _r		--	2.3	--	nS
Turn-Off Delay Time	t _{d(off)}		--	42	--	nS
Turn-Off Fall Time	t _f		--	2.8	--	nS
Total Gate Charge	Q _g	V _{DS} =20V,I _D =12A, V _{GS} =4.5V	--	5.6	--	nC
Gate-Source Charge	Q _{gs}		--	1.3	--	nC
Gate-Drain Charge	Q _{gd}		--	2.5	--	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =12A	--	0.9	1.4	V



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P-CH Electrical Characteristics (TA=25°C unless otherwise noted)

Parameter	Symbol	Condition	Rating			Unit
			Min	Typ	Max	
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=-250\mu A$	-40	--	--	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=-40V, V_{GS}=0V$	--	--	-1	μA
Gate-Body Leakage Current	I_{GSS}	$V_{GS}=\pm 10V, V_{DS}=0V$	--	--	± 10	μA
On Characteristics (Note 3)						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=-250\mu A$	-1.0	-1.5	-2.0	V
Drain-Source On-State Resistance	$R_{DS(ON)}$	$V_{GS}=-10V, I_D=-8A$	--	--	30	m Ω
		$V_{GS}=-4.5V, I_D=-4A$	--	--	50	m Ω
Forward Transconductance	g_{FS}	$V_{DS}=-5V, I_D=-8A$	6	--	--	S
Dynamic Characteristics (Note4)						
Input Capacitance	C_{Iss}	$V_{DS}=-15V, V_{GS}=0V,$ $F=1.0MHz$	--	1005	--	PF
Output Capacitance	C_{OSS}		--	105	--	PF
Reverse Transfer Capacitance	C_{rss}		--	80	--	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	$t_{d(on)}$	$V_{DD}=-20V, R_L=2.3\Omega$ $V_{GS}=-4.5V, R_{GEN}=6\Omega$	--	20	--	nS
Turn-on Rise Time	t_r		--	12.5	--	nS
Turn-Off Delay Time	$t_{d(off)}$		--	49.5	--	nS
Turn-Off Fall Time	t_f	$V_{DS}=-20V, I_D=-12A$ $V_{GS}=-4.5V$	--	4.8	--	nS
Total Gate Charge	Q_g		--	10	--	nC
Gate-Source Charge	Q_{gs}		--	2.6	--	nC
Gate-Drain Charge	Q_{gd}		--	3.2	--	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 3)	V_{SD}	$V_{GS}=0V, I_S=-8A$	--	--	-1.4	V

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board, $t \leq 10$ sec.
3. Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$.

Characteristics Curves

N- Channel Typical Electrical and Thermal Characteristics (Curves)

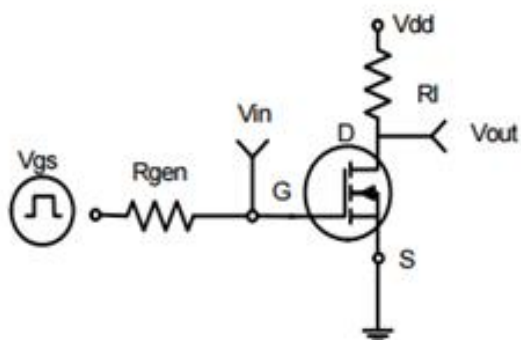


Figure 1: Switching Test Circuit

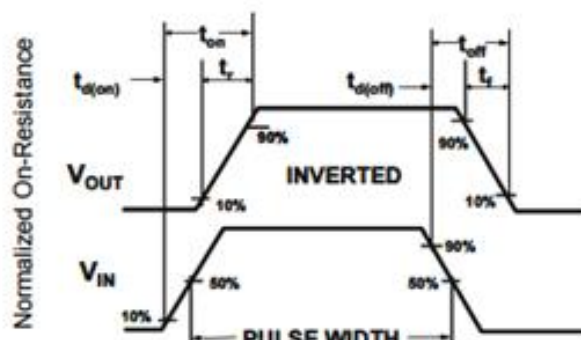


Figure 2: Switching Waveforms

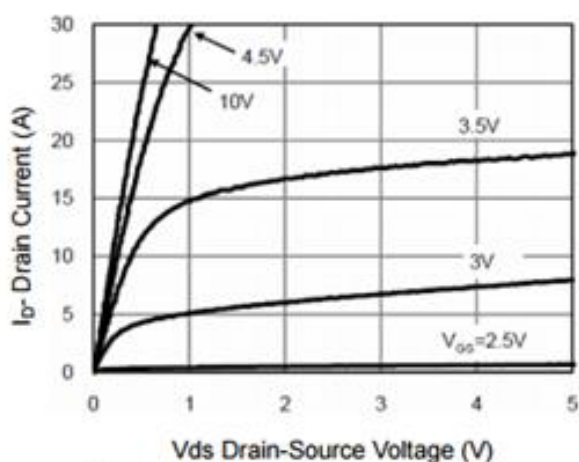


Figure 3 Output Characteristics

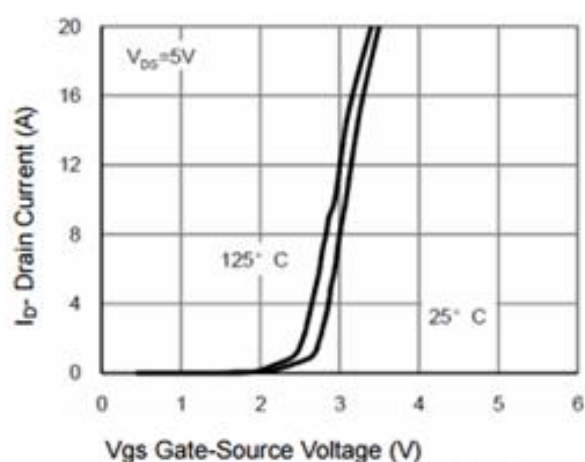


Figure 4 Transfer Characteristics

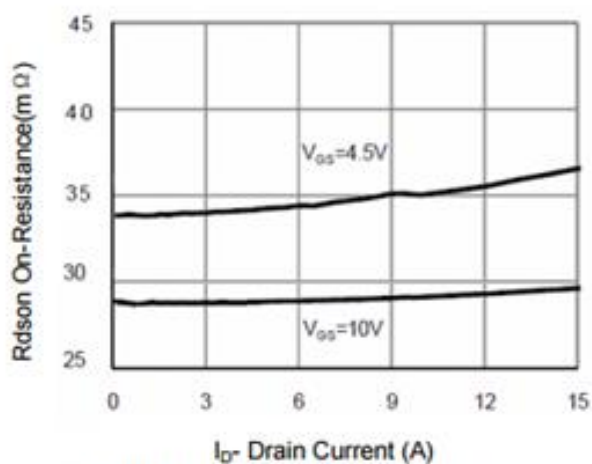


Figure 5 Drain-Source On-Resistance

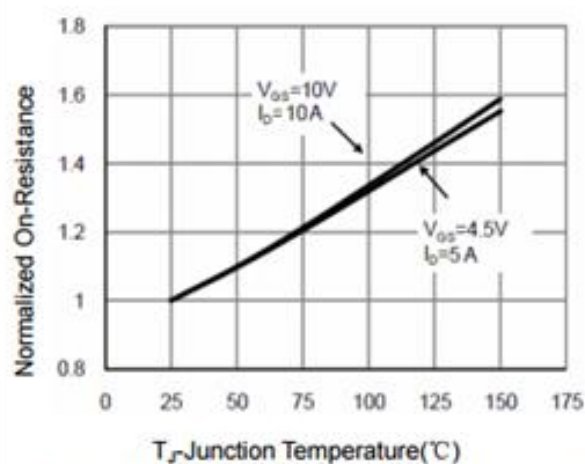
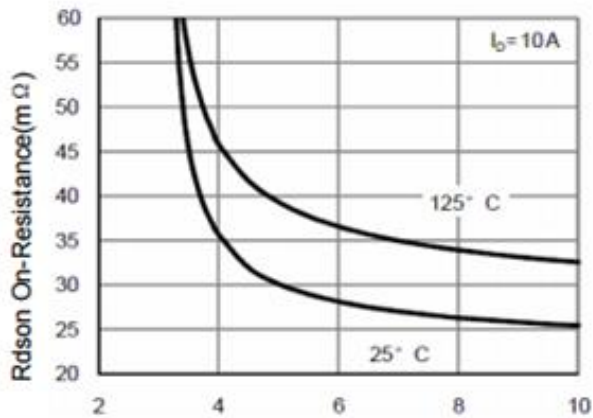
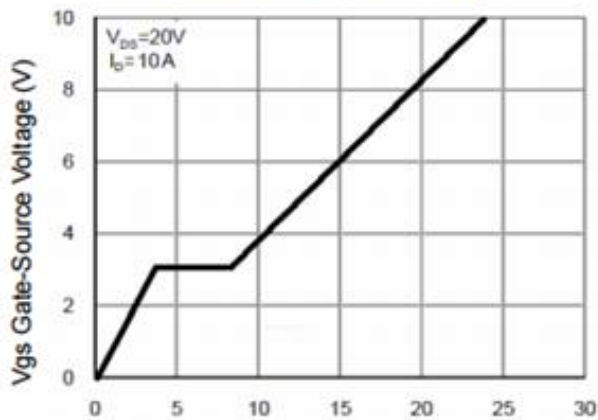


Figure 6 Drain-Source On-Resistance



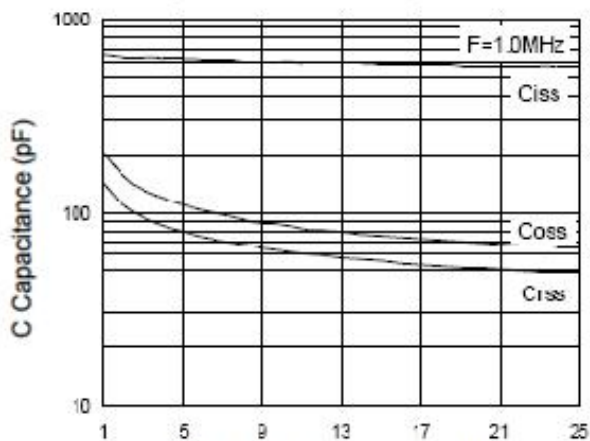
Vgs Gate-Source Voltage (V)

Figure 7 Rdson vs Vgs



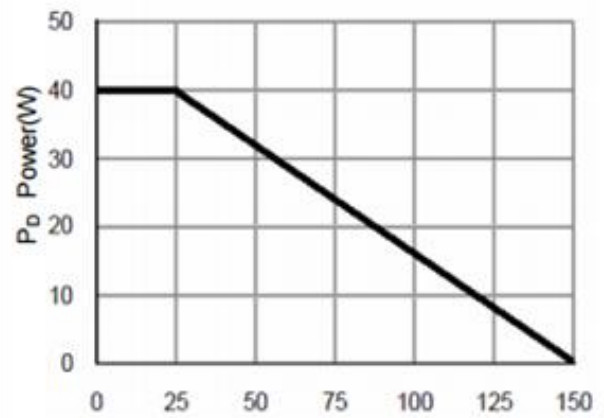
Qg Gate Charge (nC)

Figure 9 Gate Charge



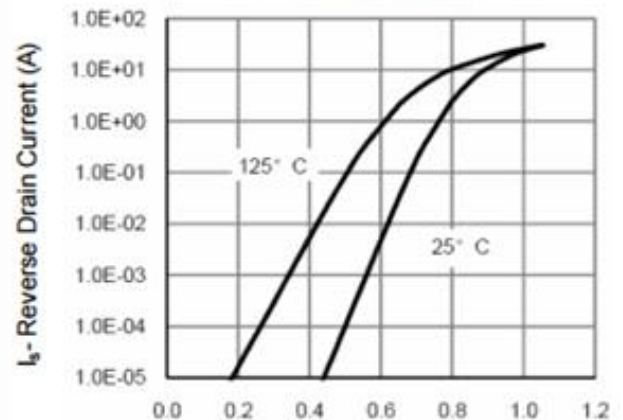
Vds Drain-Source Voltage (V)

Figure 11 Capacitance vs Vds



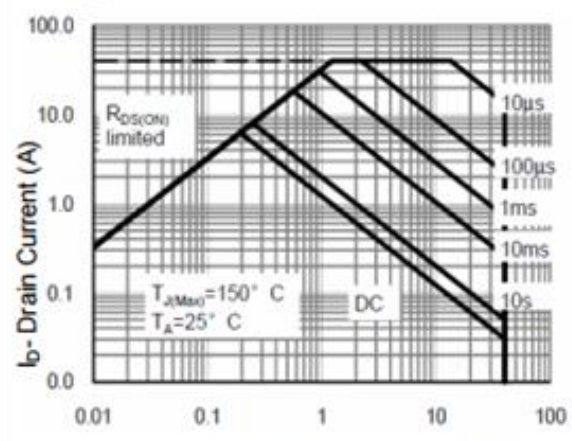
Tj Junction Temperature (°C)

Figure 8 Power Dissipation



Vds Drain-Source Voltage (V)

Figure 10 Source- Drain Diode Forward



Vds Drain-Source Voltage (V)

Figure 12 Safe Operation Area

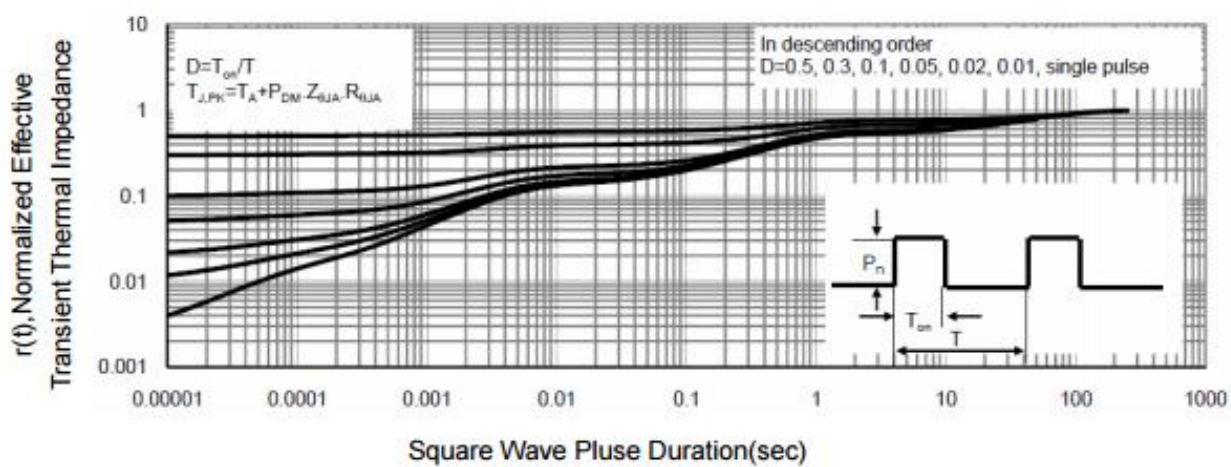


Figure 13 Normalized Maximum Transient Thermal Impedance

P- Channel Typical Electrical and Thermal Characteristics (Curves)

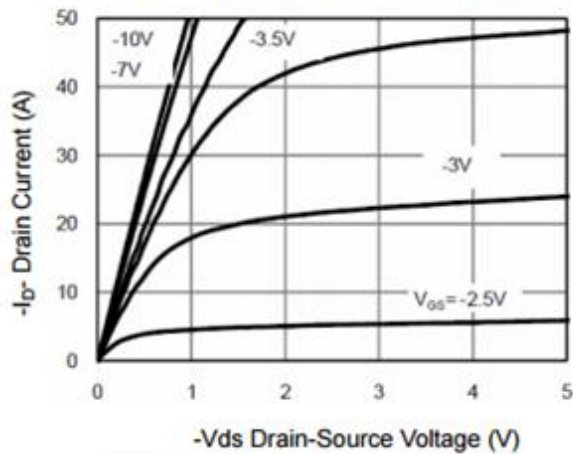


Figure 1 Output Characteristics

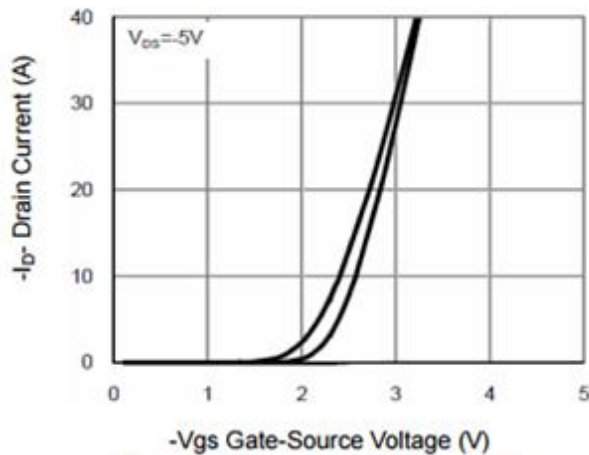


Figure 2 Transfer Characteristics

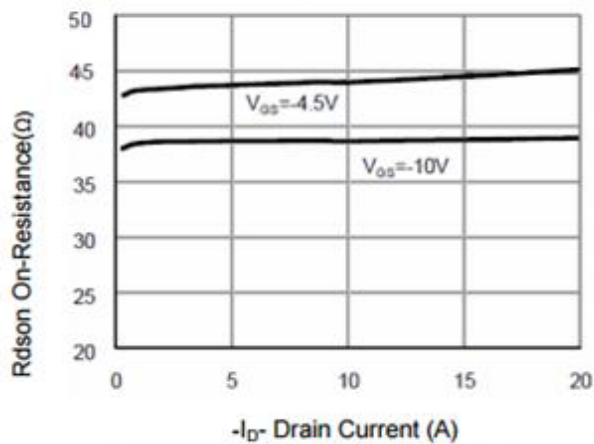


Figure 3 Rdson- Drain Current

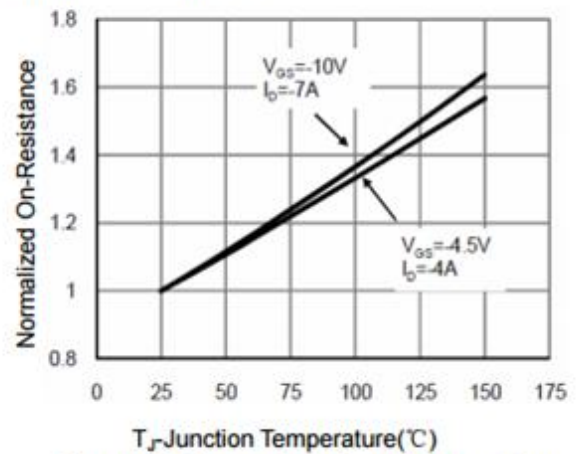


Figure 4 Rdson-Junction Temperature

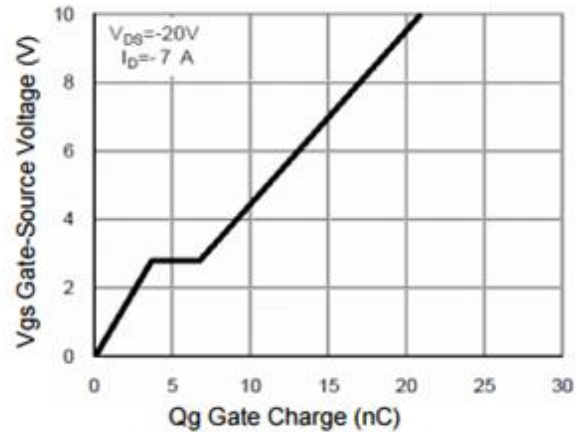


Figure 5 Gate Charge

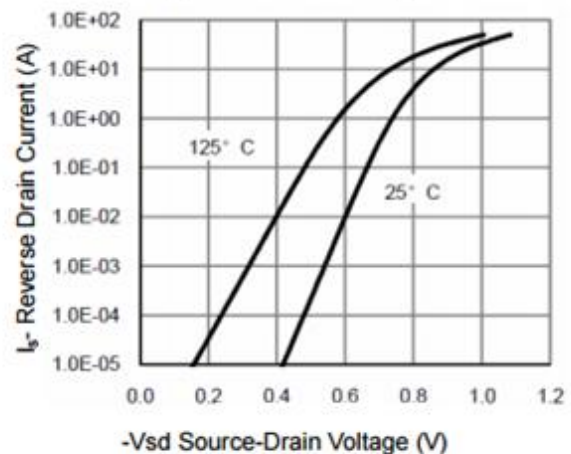


Figure 6 Source- Drain Diode Forward

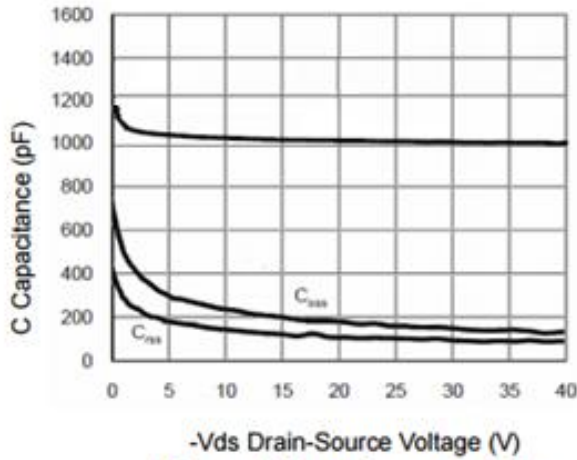


Figure 7 Capacitance vs Vds

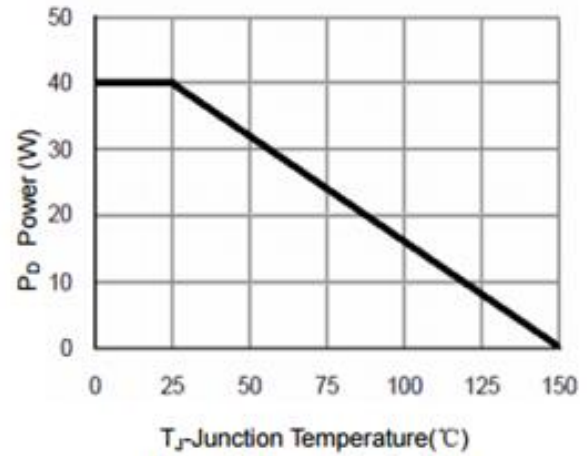


Figure 9 Power Dissipation

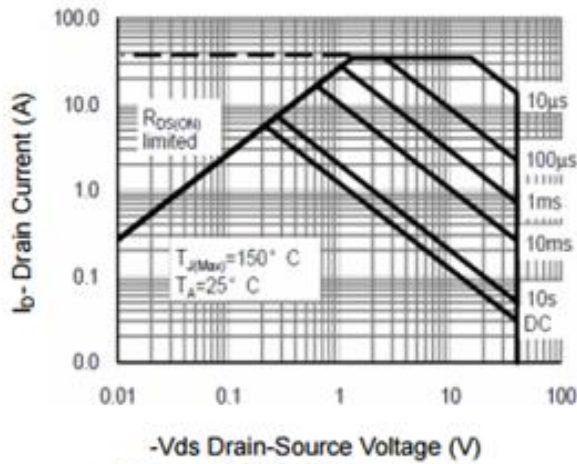


Figure 8 Safe Operation Area

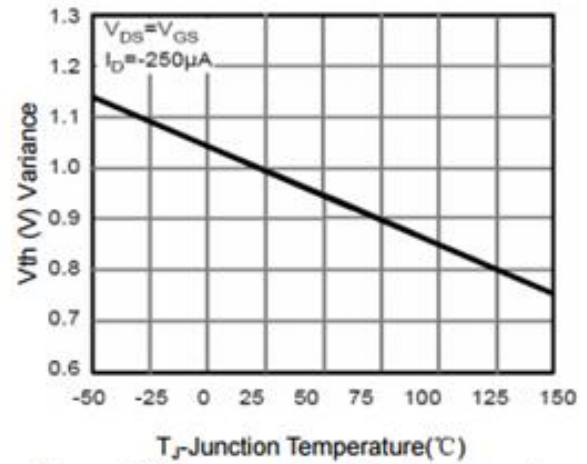


Figure 10 $V_{GS(th)}$ vs Junction Temperature

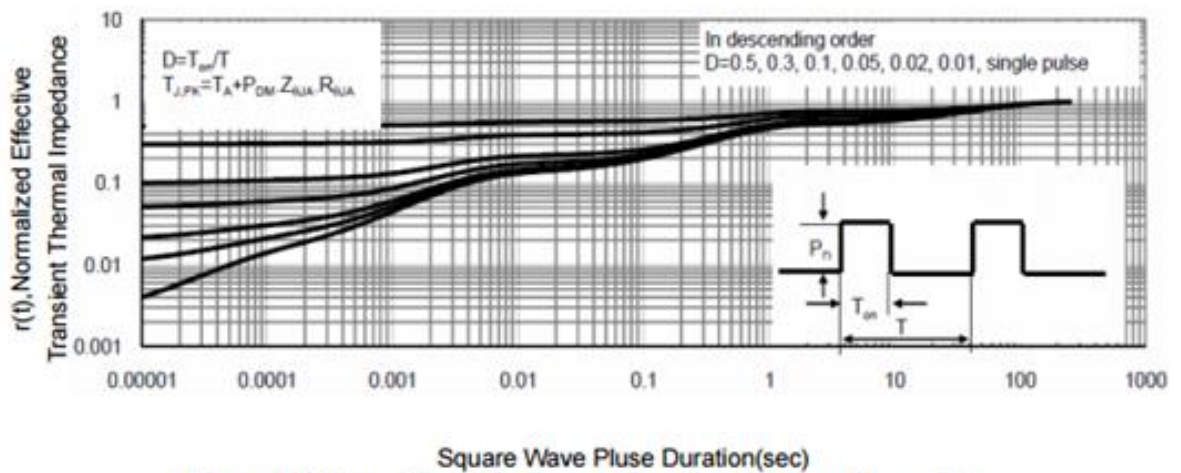


Figure 11 Normalized Maximum Transient Thermal Impedance